



Traceability NA TC Chapter

SEMICON West 2017 Meetings

Monday, July 10

San Francisco Marriott Marquis, San Francisco, California

11:00 – 12:00

AGENDA

	Time
1 Welcome/Call to Order	11:00-11:15
1.1 Introductions	
1.2 Required Elements (Membership Requirements, Antitrust and Intellectual Property Reminders, and Effective Meeting Guidelines)	
1.3 Agenda Review	
2 Review of Previous Meeting Minutes (including open Action Items review)	11:15-11:20
3 Liaison Reports	11:20-11:25
3.1 Japan TC Chapter	
4 Staff Report	11:25-11:30
5 Ballot Review (including safety and IP checks)	11:30-11:35

#	When	SC/TF/WG	Details
6061	Cycle 7-2016	5Yr Review TF	Reapproval of SEMI M12-0706 (Reapproved 1011): <i>Specification for Serial Alphanumeric Marking of the Front Surface of Wafers</i>
6062	Cycle 7-2016	5Yr Review TF	Reapproval of SEMI M13-0706 (Reapproved 1011): <i>Specification for Alphanumeric Marking of Silicon Wafers</i>



6 Subcommittee & Task Force Reports (including leadership and TF changes) 11:35-11:40

- 6.1 Traceability Five Year Review Task Force
- 6.2 T5 Revision Task Force (NEW!)

7 Old Business Standards due for Five-Year Review 11:40-11:45

- 7.2 SNARFs approaching Three-Year Document Development Project Period

8 New Business 11:45-11:50

- 8.1 New TFOFs & SNARFs
- 8.2 New Ballot(s) Submission Summary
- 8.3 Introduce Hardware Security Activity – Yaw Obeng (NIST)
- 8.4 IRDS Groups Update – Yaw Obeng (NIST)

9 New Action Item Review 11:50-11:55

10 Next Meeting (*tentative*) 11:55-12:00

- 10.1 Monday, November 06, 2017 SEMI HQ, Milpitas CA
 - 5 Year Review Traceability TF (9:00 – 10:00)
 - T5 Revision TF (10:00 – 11:00)
 - Traceability TC Chapter (11:00 – 12:00)

11 Adjournment

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